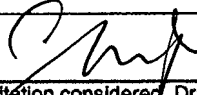


Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-087002	Application No. 10/623,609
	Applicant Satoshi Seo et al.		
	Filing Date July 22, 2003	Group Art Unit 1774	

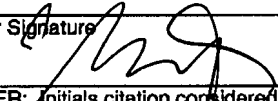
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							Yes	No
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	AW							

Examiner Signature 	Date Considered 10/24/07
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

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		Filing Date July 22, 2003	Group Art Unit 1774

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Examiner Initial	Desig. ID	Document
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(37 CFR §1.98(b))			

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CH	AW	JP11/307263	11/05/1999	JAPAN	—	—	Abstract	
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Examiner Signature

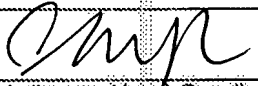
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	ADD	
	AEE	
	AFF	

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